

**Search Notes**

Application/Control No.

10/620,345

Examiner

Henry Vuu

Applicant(s)/Patent under  
Reexamination

WENG ET AL.

Art Unit

2179

**SEARCHED**

Class	Subclass	Date	Examiner
715	513	11/2/2006	HV
715	528	11/2/2006	HV
715	775	11/2/2006	HV

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	10/30/2006	HV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner